

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/672,550	UCHIDA, KAORU	
Examiner	Art Unit	
Alex Liew	2624	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
382/124-127 limited to text search	1/6/2007	AL			
382/124-127 limited to text search	5/28/2007	AL			
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